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WX044P04P3

Enhancement Mode P-Channel Power MOSFET

PDFN3X3/PMOS/-40V/±20V/-1.65V/-10A/38.4mΩ

Rev0.5

-40V, 38.4mΩ, -10A, Single P-Channel

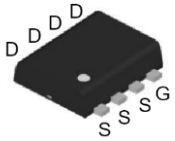
1.Features

- -40V MOSFET technology
- Low on-state resistance
- Fast switching
- Vgs±20V
- 100% RG Tested
- 100% UIS Tested

V_{DS}	$R_{DS(on)}$ Typ.	I_D Max.
-40V	38.4mΩ @ -10V	-10A
	51mΩ @ -4.5V	

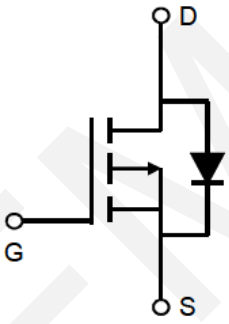
2.Applications

- Power Switching Application
- Load Switching



PDFN3X3

Pin Description



Schematic Diagram

3.Package Marking and Ordering Information

Part no.	Marking	Package	PCS/Reel	PCS/CTN.
WX044P04P3	044P04	PDFN3X3	5,000	50,000

4.Absolute Max Ratings at Ta=25℃ (Note1)

Parameter	Symbol	Maximum	Units
Drain to Source Voltage	V_{DSS}	-40	V
Gate to Source Voltage	V_{GSS}	±20	V
Drain Current (DC)	I_D	-10	A
Drain Current (Pulse), PW≤300μs	I_{DP}	-40	A
Total Dissipation	P_D	2.6	W
Avalanche Energy, Single Pulsed	E_{AS}	45.56	mJ
Junction Temperature	T_j	150	℃
Storage Temperature	T_{stg}	-55 to +150	℃

Note 1: Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

5.Thermal Resistance Ratings (Note 2)

Parameter	Symbol	Value	Unit
Junction to Ambient	$R_{\theta JA}$	48	℃/W

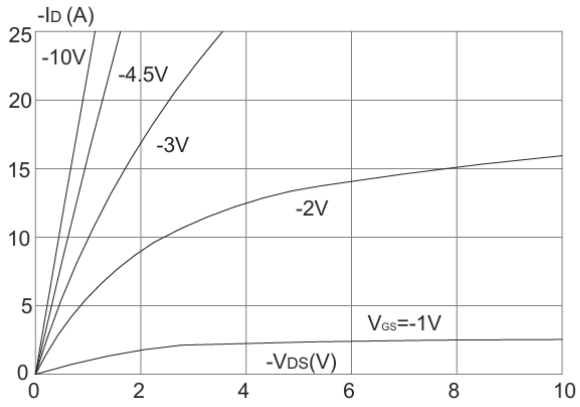
Note 2：When mounted on 1 inch square copper board t ≤ 10sec The value in any given application depends on the user's specific board design.

6.Electrical Characteristics at Ta=25℃ (Note 3)

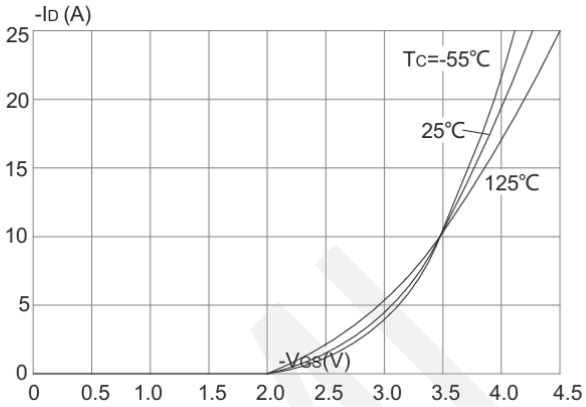
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Units
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	I_D = -250μA, V_{GS} = 0V	-40	-	-	V
Zero-Gate Voltage Drain Current	I_{DSS}	V_{DS} =-40V, V_{GS} = 0V	-	-	-1	μA
Gate to Source Leakage Current	I_{GSS}	V_{GS} = ±20V, V_{DS} = 0V	-	-	±100	nA
Gate Threshold Voltage	$V_{GS(th)}$	V_{DS}=V_{GS}, I_{DS}=-250μA	-1.0	-1.65	-2.5	V
Static Drain to Source On-State Resistance	$R_{DS(on)}$	I_D =-10A, V_{GS} =-10V	-	38.4	46	mΩ
		I_D =-8A, V_{GS} =-4.5V	-	51	66	mΩ
Input Capacitance	C_{iss}	V_{GS}=0V, V_{DS}=-20V, Frequency=1.0MHz	-	982	-	pF
Output Capacitance	C_{oss}		-	72	-	pF
Reverse Transfer Capacitance	C_{rss}		-	57	-	pF
Turn-ON Delay Time	$t_{d(on)}$	V_{DS} = -20V, V_{GS} = -10V, I_D = -4A, R_{GEN} =3Ω	-	10.3	-	ns
Rise Time	t_r		-	4.3	-	ns
Turn-OFF Delay Time	$t_{d(off)}$		-	39	-	ns
Fall Time	t_f		-	46.5	-	ns
Total Gate Charge	Q_g	V_{DS} =-20V, V_{GS} =-10V, I_D =-4A	-	17.3	-	nC
	Q_{gs}		-	3.2	-	nC
	Q_{gd}		-	4.3	-	nC
Diode Forward Voltage	V_{FSD}	I_S =-10A, V_{GS} = 0	-	-	-1.2	V

Note 3：Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

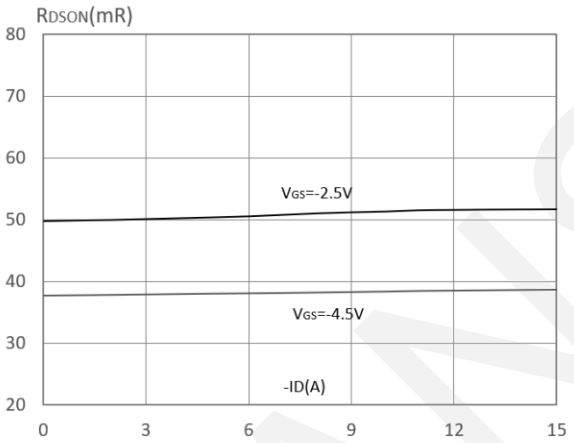
7.Typical electrical and thermal characteristics



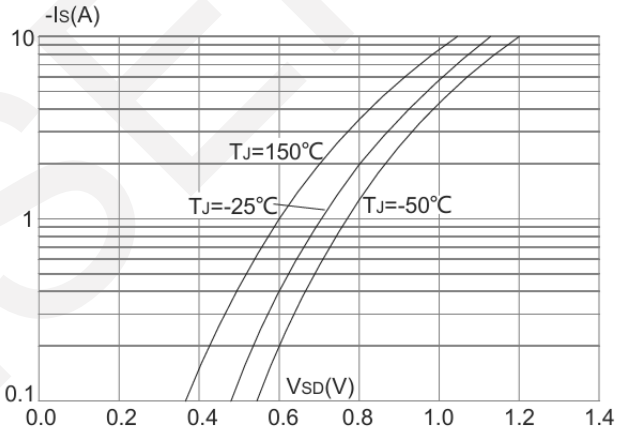
Output Characteristics



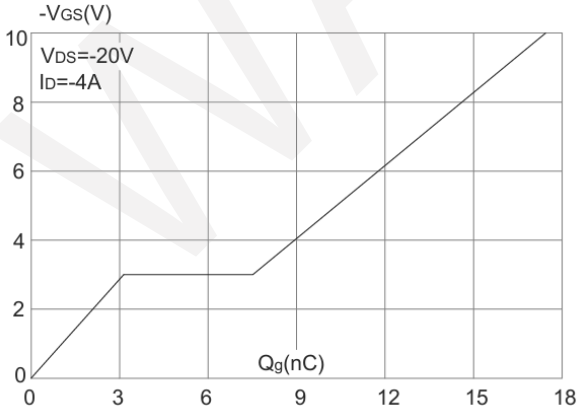
Transfer Characteristics



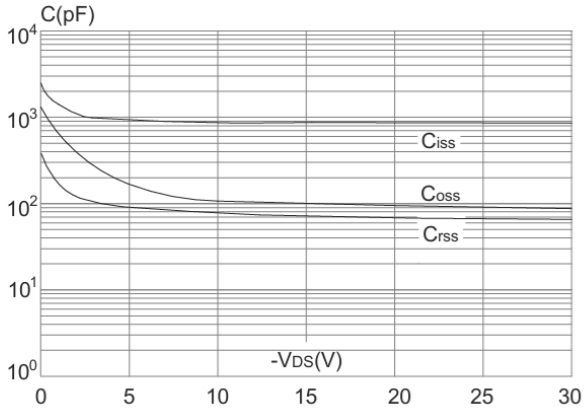
Rdson-Drain Current



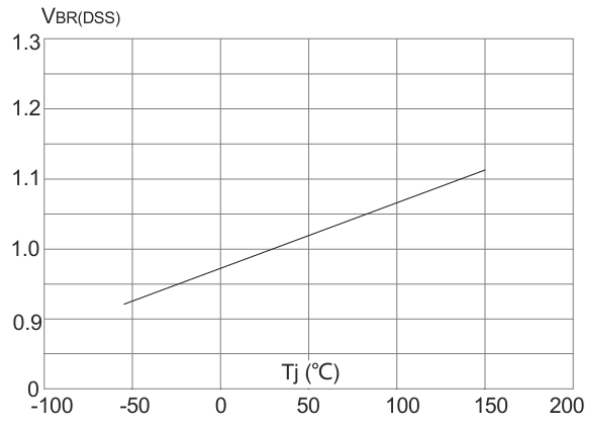
Body Diode Characteristics



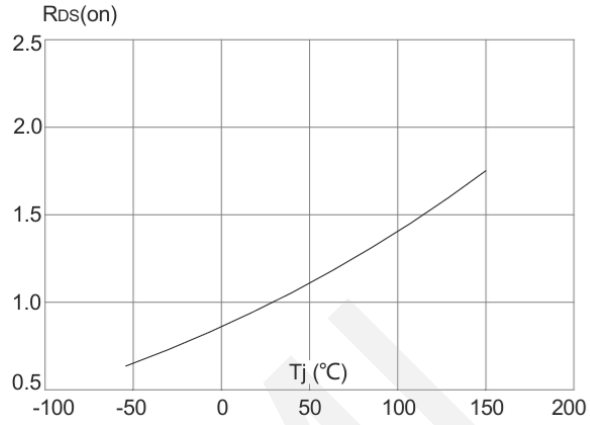
Gate Charge



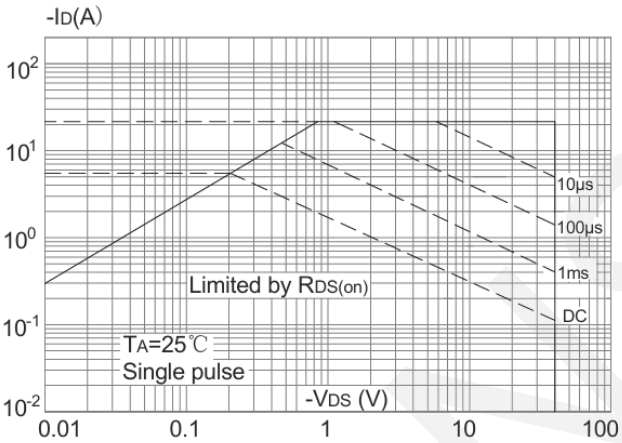
Capacitance Characteristics



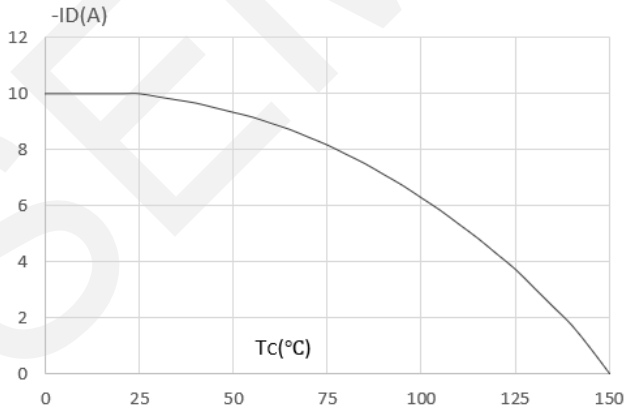
Normalized Breakdown Voltage vs. Junction Temperature



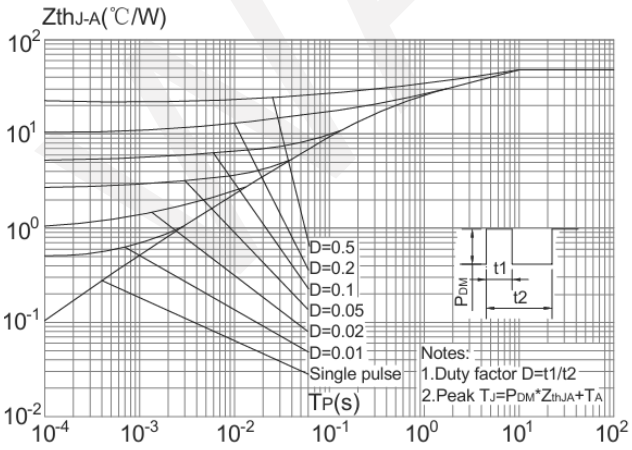
Normalized on Resistance vs. Junction Temperature



Maximum Safe Operating Area

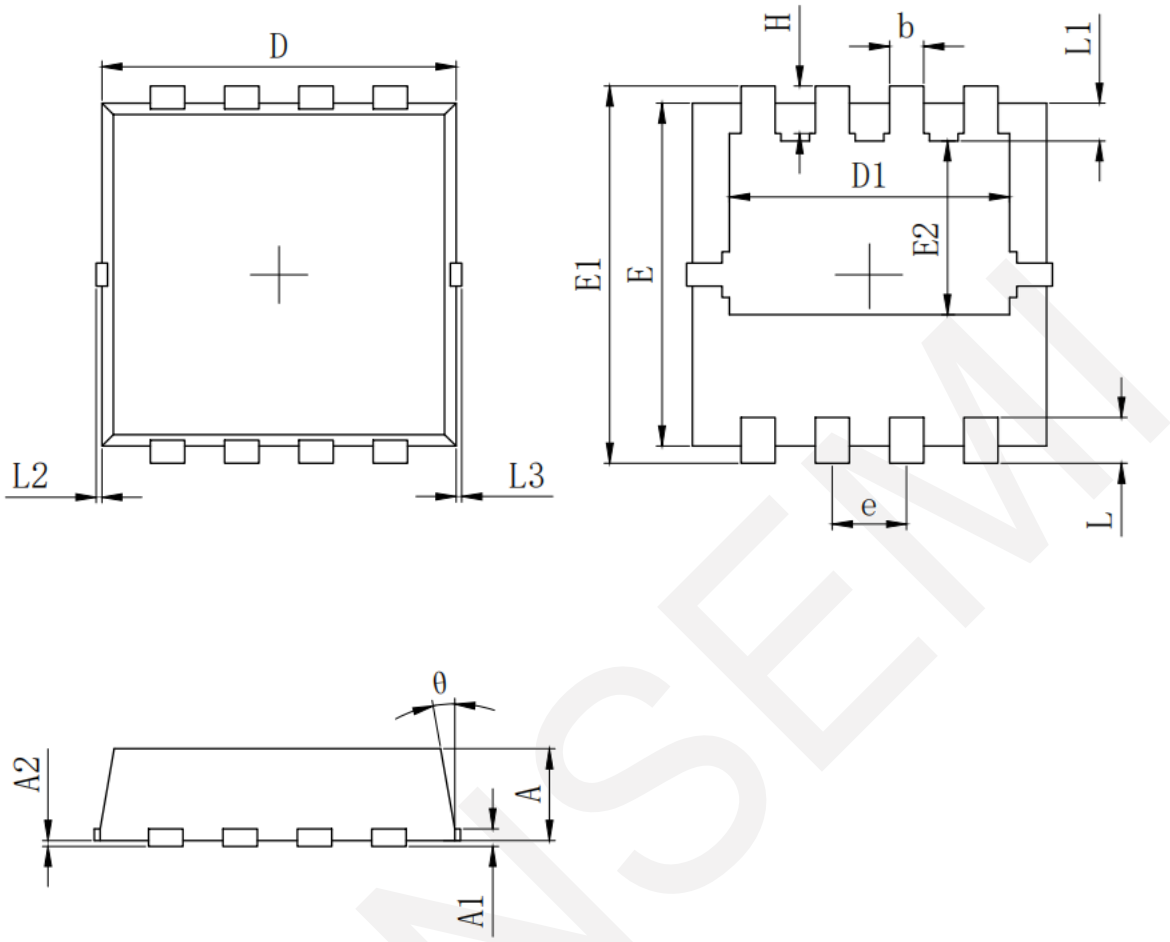


Maximum Continuous Drain Current vs. Ambient Temperature



Normalized Maximum Transient Thermal Impedance

8.Package Dimensions



SYMBOL	MILLIMETER		
	MIN	Typ.	MAX
A	0.700	0.800	0.900
A1	0.152 REF.		
A2	0~0.05		
D	3.000	3.100	3.200
D1	2.300	2.450	2.600
E	2.900	3.000	3.100
E1	3.150	3.300	3.450
E2	1.320	1.520	1.720
b	0.200	0.300	0.400
e	0.550	0.650	0.750
L	0.300	0.400	0.500
L1	0.180	0.330	0.480
L2	0~0.100		
L3	0~0.100		
H	0.315	0.415	0.515
θ	8°	10°	12°

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